

# Solid Solder Deposit: An Alternative Surface Finish

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A number of surface finishes gained popularity in an effort to overcome the limitations of solder levelling. Included among these were organic coatings, Nickel/Gold and immersion Tin.

While these provided better uniformity than the HASL coating they also presented problems associated with shelf life, a limited number of thermal excursions that could be sustained and poor wetting at assembly. Solid Solder Deposits (SSDs) were developed specifically to overcome the defects associated with circuit board surface finish and solder paste printing.

Over 60% of defects in the assembly process have been attributed to the paste printing operation. These defects include solder shorts, insufficient solder/opens, and component skew.

With the implementation of higher density devices, i.e. components with pad pitch spacing of 0.5mm and below, assembly yields declined dramatically. Yields were further exacerbated by the lack of planarity of the hot air solder levelling surface finish. Further hot air levelling could cause thermal degradation, which may result in warp, delamination or solder mask related failures.

## Solid solder deposits

While several methods exist to form solid solder deposits (SSDs), they were developed with a common goal: to perform macroplanar metal deposits on all surface mount lands on the bare printed circuit board and eliminate solder paste at assembly (Fig. 1). Deposits had a sufficient volume

thickness so that no additional metallisation was required at assembly. As the manufacture of complex devices became more challenging, SSDs gained popularity. While a flat surface topography was desirable for conventional surface mount applications, SSDs have evolved and are now formed with both flat and spherical geometries for applications in the PCB, SMD and microelectronics industries. These include pre-formed solder deposits for:

- 1) flat pads
- 2) mechanical connections
- 3) pin insertion thru-holes
- 4) multi-tiered deposits
- 5) solder bumps for semiconductor wafers, and
- 6) solder spheres for Chip Scale and BGA packages.

## The SSD process

The SSD process is comprised of three steps:

- Solder paste print using conventional methods;
- Reflow/formation of the metal deposits using equipment licensed specifically for this purpose;
- Cleaning in the event that a water-soluble solder paste is employed.

In the SSD process a very rudimentary paste printer is employed for products as dense as 200µm pitch. Much of the skill and ac-

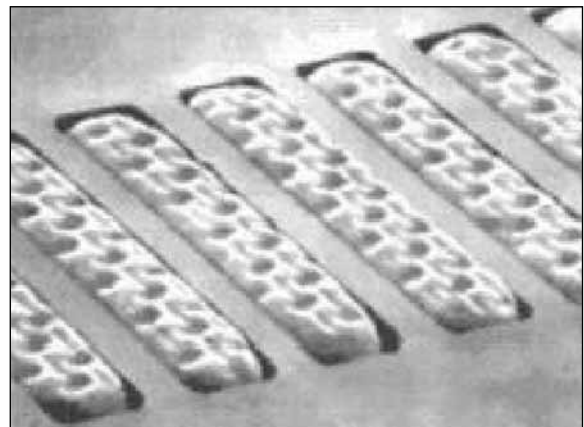
curacy required in conventional processing is not required in SSD processing, for a number of reasons:

- The stencil used in the SSD process is normally 100µm thick with increased apertures, or an overprint. Most assembly sites use a 150-200µm foil. This makes the SSD paste printing process much more repeatable due to the aspect ratio of the apertures on the stencil vs. the foil thickness.

- While the viscosity of solder paste for conventional processing is thick and difficult to print (i.e. 850 kcps), solder pastes used in the SSD process are typically 600 kcps and this, in combination with the flux carrier employed, makes the paste quite runny.

- Registration in the SSD process is not critical. Visual alignment by the operator is normally done even on high-density designs, obviating the need for optical registration systems. Misregistration or shorts evident after paste printing are eliminated during solder reflow and formation, as described further below. This provides more process latitude than conventional paste printing.

Figure 1 - SSD "Flat Pad" on 0.5mm pitch SMD



### The reflow/formation step

Subsequent to paste print, panels or arrays are loaded into the Reflow/Formation system. A tensioned stainless steel mesh is lowered directly onto the panels or arrays, with the mesh sitting in intimate contact with the wet paste. A hot air knife then travels over the boards in the SSD system. The travelling heat source is designed to insure a very brief thermal excursion. While solder paste manufacturers normally recommend a reflow stage of 30-90s for eutectic solder at a temperature of 180-235°C, in the SSD process time at temperature is normally less than 20s. The flux carrier used in the paste, and the absence of components during solder formation, both facilitate rapid reflow.

The mesh used in the SSD process acts as a die or mold to flatten (planarise), shape and remove excess solder. During reflow the solder wicks towards the land and up through the mesh. Alternatively, solder spheres (or bumps in wafer bumping) can be formed with the mesh screen acting as a conduit for excess solder to rise and be removed.

The mesh controls solder in the Z axis and enables volatiles present in the solder paste to escape during reflow and SSD formation, which occur simultaneously. Excess solder wicks above the mesh during reflow in the form of solder balls. Even if excess solder re-deposits on the boards after many cycles, i.e. on the surface of the solder mask, it is easily removed in the absence of components. (Note that the mesh is normally cleaned one time per shift to remove residual solder balls.)

In the SSD method described the solid solder deposits have a macro-planar surface finish with an embossed surface topography created by the mesh screen. This "textured" finish creates a larger surface area to retain a high volume of tack flux at subsequent assembly. Further, the conduit created by the mesh enables the solder to be formed

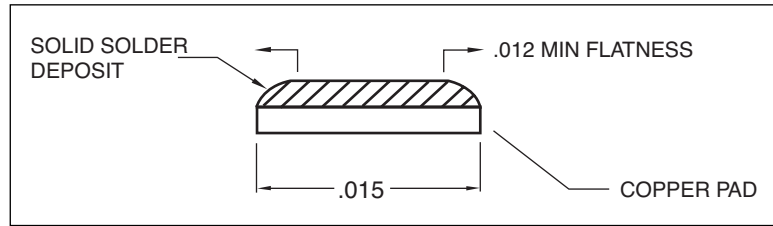


Figure 2 - SSD planarity specification

without voids. After reflow, panels or arrays are quenched with a lower temperature-cooling pass and boards exit the Reflow/Planarisation system.

### PCB capabilities/design considerations

The wire-mesh screen process provides a very defined volume of solder, which cannot be accomplished with normal stencil printing. Shorts and solder balls at assembly are eliminated and the copper lands are encapsulated in a thick solder deposit which increases bare board shelf life. The most common products processed with SSDs are double sided surface mount within the parameters reflected in Table 1. Other design considerations on the board level include:

- Vias immediately adjacent to sites that require a solder deposit should be plugged or tented with solder mask to prevent solder from wicking into the vias;
- Two lands connected to one another that require solder deposits of varying heights, or different alloys, should be isolated by a solder mask web. Depending on the board fabricator's capabilities there may or may not be solder mask dams or webs between surface mount lands. BGA sites are normally non-solder mask defined

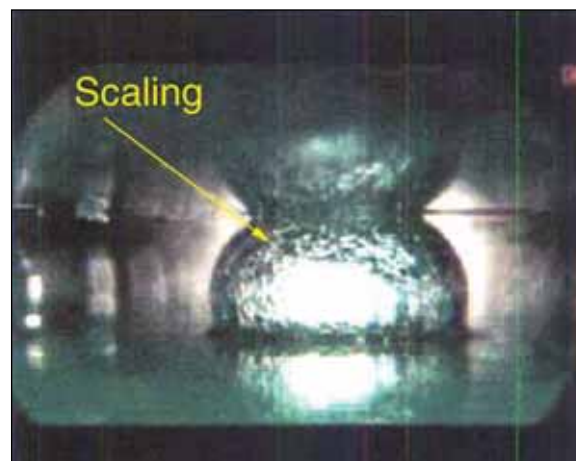
due to thermal cycling performance.

### Alloy composition/lead free alloys

SSDs are processed with a number of different alloy compositions to meet end users diverse requirements. While eutectic 63/37 solder is most commonly used for conventional surface mount applications, Lead free solders have gained momentum and high Lead content alloys are used for some advanced applications (i.e. wafer bumping and the formation of solder spheres on ceramic components).

Contingent on PCB design, multiple alloys may also be recommended where it is desirable to have two-tiered deposits reflowing at different temperatures. Multi-tiered deposits can be particularly advantageous in loading edge connectors through multiple soldering operations. Table 2 reflects some of the alloys most commonly used in SSD formation. It should be noted that Nitrogen is recommended for reflow of high lead content alloys.

Figure 3 -  $\mu$ BGA Sphere Photograph at 100x Magnification



Maximum Substrate Size	18" x 14"
Minimum Substrate Size	1" x 1"
Substrate Construction	FR-4, polyimid, ceramic, flexible circuits, wafers
Solder Mask	Liquid Photoimageable, Dry or Liquid/Dry Film
Cu Finish	HASL, Organic Coating, Gold, Nickel/Gold, Immersion Tin, Immersion Silver, Selective Solder
Board Thickness	.010" to .250"
Tooling Holes	.125" x 2 Recommended
Solderability	Mil P55110

Table 1 - Solid solder deposit capabilities/design considerations

### Solder volume/deposit height

Tables 3 and 4 show, respectively, SSD volume and SSD thickness/uniformity of conventional SMD processes for different types of packages assembled on the board. An ancillary benefit of employing SSD "flat pads" on the bare board may be the increase in deposit height as the solder reaches a meniscus during subsequent reflow at assembly. This height increase, reflected in Table 5, has been attributed to compensating for up to +/- 178µm of lead coplanarity defects.

### Solder deposit planarity/sphericity

While SSD flat pads are common on the board level, semiconductor wafers are normally bumped, and solder spheres are formed on components (i.e. BGAs) using modifications of the SSD process. Planarity specifications vary due to a number of criteria including board design, land configurations, pitch, buried vias in the pads or vias connected to the pads which can effect solder volume, as well as alloy. Further, it is common for deposits to have a "shoulder" as depicted in Fig. 2.

With SSD the component sits on the centre of the solid solder pad with an equal amount of solder in front of and behind the pin, achiev-

ing a symmetrical solder fillet.

As with the comparison of paste print parameters for flat pads vs. conventional processing, SSD formed spheres should meet the end-users current criteria for solder ball placement. Conventional metallisation in the manufac-

ture of Ball Grid Arrays (BGAs) and Chip Scale Packages (CSPs) is the placement of solder balls on the package to form the interconnection between the component and the printed circuit board. Assembly yields are sensitive to ball height variations across an array, and solder spheres should be uniform and exhibit minimal oxides. The majority of solder balls being placed are between 710µm to 890µm in diameter with uniformity required of +/- 25µm. SSD formed spheres are most commonly between 304µm and 760µm in diameter.

While implementation of SSD technology on the board level was driven primarily to improve first

pass yields, on the package level the primary advantage is to reduce raw materials costs. Rather than placing solder balls on an array, the SSD process uses solder paste as the medium to form spheres. This represents a significant capital equip-

materials savings. SSD technology also eliminates the requirement to use nitrogen when forming Sn63/Pb37 solder spheres, providing further cost benefits.

### Ionic cleanliness

Ionic contamination can represent a significant factor causing degradation or failure of electronic assemblies. Residual contamination can result in surface electrical leakage and chemical, galvanic and electrolytic corrosion. It is important to quantify contamination levels to insure that all products perform to their intended level.

Many of the problems associated with ionic contamination at assembly have been reduced due to changes in solder mask materials. Dry film resists used many years ago were porous and prone to retaining high levels of contaminants which could contribute to white hazing, blistering and a high incidence of solder balls at assembly. Liquid photoimageable (LPI) solder masks exhibit fewer contaminants and are now used in the manufacture of most PCBs (i.e. over 90% of circuit boards processed in the U.S. are produced with LPIs). A common method of testing ionic contaminants is measuring the electrical resistivity of a known volume of rinse solution used to extract and remove

Alloy	Melting Range °C	Element Key
Sn63Pb37	183	Sn - Tin
Sn62Pb36Ag2	179-189	Pb-Lead
Sn96.5Ag3.5	221	Ag-Silver
Sn43Pb43 Bi14	144-163	Bi-Bismuth
Sn95Ag5	221-245	
SnAg3.8Cu.7	217-221	

Table 2 - SSD Alloys - Note: numbers represent the weight percent of the element that is included in the alloy  
Table 3 - SSD Volume - Conventional SMD

	Volume/Cubic Mils Per Lead
BGA	1900-1950
PLCC	4000-6100
QFP	1800-1900
SOIC	4000-5700
TSOP	1400-1800

	Range	Uniformity
BGA	.0019-.0025	± .0003"
PLCC	.0019-.0029	± .0002"
QFP	.0019-.0024	± .0002"
SOIC	.0019-.0029	± .0002"
TSOP	.0019-.0022	± .0002"

Table 4 - SSD thickness/uniformity - Conventional SMD

Table 5 - SSD meniscus height increase - Conventional SMD

Pitch	SSD Height	After Reflow	% Increase
.050"	.0035"	.0050"	42%
.031"	.0035"	.0045"	28%
.025"	.0035"	.0045"	28%
.019"	.0033"	.0041"	24%

the ionisable contaminant off a known surface area. An ionographic unit can be used to test for contamination of boards after SSD processing and cleaning. With a pass/fail limit of about 1milligram/square cm results ensure that all boards fall well within acceptable levels.

### Assembly process

The assembly process is simplified with the implementation of SSDs. An adhesive flux is applied to boards prior to assembly via stencil, spray, immersion, dispensing or by pin transfer. Flux chemistries available include no clean, water-soluble and rosin based formulations. If a water soluble flux is selected it can be dispensed in beads across a row of pads to improve line efficiency and reduce cycle times. Subsequent to application of the flux, components are placed followed by conventional reflow soldering.

The flux activates the solder and has sufficient tack properties to prevent component movement during assembly. The reflow profile used is normally determined by the profile of the correspondent solder paste that contains the same paste flux. Following reflow products are inspected and tested.

When qualifying the SSD process the assembly sites inspection and test should include verifying the wetting angles of the solder joint, insuring a very thin intermetallic layer between the solder and the Copper pad, and analysing alloy composition (Fig. 4).

### Summary

The trend towards finer pitch surface mount devices has accelerated over the past decade. At the same time prices for consumer electronics in particular have experienced continuing downward pressure. This has resulted in the electronics industry's assessing different methods to increase manufacturing yields and to effectively reduce costs. While margins have eroded in some sectors, the cost of environmental compliance has risen. In response to this market pressure electronics manufacturers have increasingly looked at ways to remain competitive. SSD technology has evolved to meet a number of different application requirements.

Several iterations were developed and include deposits for applications including flip chip designs (25µm SSD on 228µm pitch) as well as forming 1,000µm deposits for mechanical connections. The

technology can benefit low-density computer applications, mid-density medical, test and measurement and telecommunications (mobile phones and satellites), and the highest density products currently manufactured for data processing, components and consumer electronics. They are employed in the manufacture of PCMCIA cards, flight data recorders, connectors and military electronics. Since their introduction in the early and mid - 1990's, SSDs have been subjected to rigorous proprietary testing by a variety of end users. These have included reliability testing with respect to thermal and power cycling, solderability and vibration. A number of major advantages have been identified using SSDs over conventional processing. In addition to providing excellent planarity/uniformity of the metal deposits prior to assembly, the use of SSDs:

- lowers costs compared to processes currently used;
- reduces the defect rate of solder connections;
- is well suited to high density devices;
- is less complex than traditional methods;
- reduces cycle time at assembly and improves line efficiency;
- significantly enhances long term reliability of electronic assemblies;
- is environmentally friendly.

SSD applications, at the board level, represent an alternative surface finish for PCB assembly in different sectors such as automotive, computer, medical and telecommunications.

SSD technology provides significant advantages over conventional processing and accelerates the introduction of new products into the marketplace using the electronic industry's existing infrastructure.

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